



# STIC EIC 2100 138635

## Search Request Form (112)

Today's Date:

11/24/04

What date would you like to use to limit the search?

Priority Date:

04/26/99

Other:

Name

Amh Ly

AU

2162

Examiner #

77831

Room #

3A4039

Phone

571-272-4039

Serial #

09/551,809

Format for Search Results (Circle One):

☒ PAPER

☐ DISK

☐ EMAIL

Where have you searched so far?

USP DWPI EPO JPO ACM IBM TDB

IEEE INSPEC SPI

Other

Is this a "Fast & Focused" Search Request? (Circle One)

☒ YES

☐ NO

by Fri. morning before noon

A "Fast & Focused" Search is completed in 2-3 hours (maximum). The search must be on a very specific topic and meet certain criteria. The criteria are posted in EIC2100 and on the EIC2100 NPL Web Page at <http://ptoweb/patents/stic/stic-tc2100.htm>.

What is the topic, novelty, motivation, utility, or other specific details defining the desired focus of this search? Please include the concepts, synonyms, keywords, acronyms, definitions, strategies, and anything else that helps to describe the topic. Please attach a copy of the abstract, background, brief summary, pertinent claims and any citations of relevant art you have found.

Inventor: Yoshimasa Furukawa

- plural attribution record groups corresponding to each of the attributions, wherein the plural attributions record groups include a Search Key attribution record group for determining if others of the plural attribution record groups are to be decompressed

\* A ~~Search~~ Search key attribution record group is used for abstracting data.

STIC Searcher

Geoffrey St. Leger

Phone

2352.0

Date picked up

11/24/04

Date Completed

11/24/04

